

SANYO Semiconductors DATA SHEET

ExPD (Excellent Power Device)

TND314S — General Purpose Driver for PDP Sustain Pulse Drive, Motor Drive, Switching Power Supply, and DC / DC Converter Applications

Features

- · Dual inverter.
- · Monolithic structure (High voltage CMOS process adopted).
- Withstand voltage of 25V is assured.
- Wide range of operating voltage: 4.5V to 25V.
- · Peak output current: 1A.
- Fast switching time (25ns typical at 1000pF load).
- Fully compatible input to TTL / CMOS (V_{IH}=up to 2.6V, at V_{DD}=4.5 to 25V).
- · Built-in input pull-down resistance.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Supply Voltage	V _{DD}		0 to 25	V
Input Voltage	VIN		GND-0.3 to V _{DD} +0.3	V
Allowable Power Dissipation	P _D max		0.3	W
Junction Temperature	Tj		-55 to +150	°C
Storage Temperature	Tstg		-55 to +150	°C

Recommended Operating Conditions at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Operating Supply Voltage	V _{DD}		4.5 to 25	V
Operating Temperature	Topr		-40 to +125	°C

Electrical Characteristics (AC Characteristics) at Ta=25°C, V_{DD}=18V, V_{IN}=5V

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Unit
Turn-On Rise Time	t _r	C _L =1000pF		30	45	ns
Turn-Off Fall Time	tf	C _L =1000pF		30	45	ns
Delay Time	t _D 1	CL=1000pF		25	40	ns
	t _D 2	C _L =1000pF		45	60	ns

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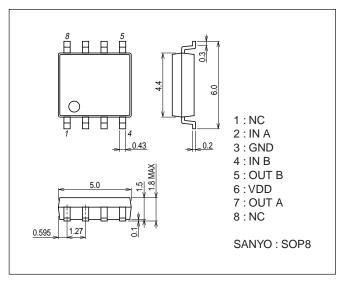
TND314S

Electrical Characteristics (DC Characteristics) at Ta=25 $^{\circ}$ C, VDD=4.5 to 25V

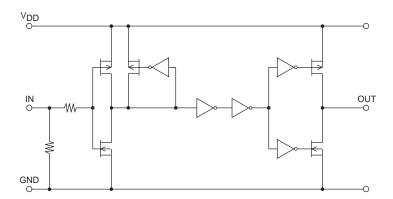
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Onit
Logic "1" Input Voltage	VIH		2.6			V
Logic "0" Input Voltage	VIL				0.8	V
Logic "1" Input Bias Current	IIN+	V _{IN} =V _{DD} =25V		40	100	μΑ
Logic "0" Input Bias Current	IIN-	V _{IN} =0V or V _{DD}	-1		1	μΑ
High Level Output Voltage	Voн	I _O =0A	V _{DD} -0.1			V
Low Level Output Voltage	VOL	IO=0A			0.1	V
V _{DD} Supply Current	Isupp	V _{DD} =10V, V _{IN} =3V, (both inputs)		1.0	4.5	mA
		V _{DD} =10V, V _{IN} =0V, (both inputs)			0.2	mA
Output High Short Circuit Pulse Current	IO+	V _{DD} =18V, PW≤10μs, V _{OUT} =0V		1.0		Α
Output Low Short Circuit Pulse Current	10-	V _{DD} =18V, PW≤10μs, V _{OUT} =18V		1.0		Α
Output On Resistance	ROUT	V _{DD} =18V, Iload=10mA, V _{OUT} ="H"		8	12	Ω
		V _{DD} =18V, Iload=10mA, V _{OUT} ="L"		6	10	Ω

Package Dimensions

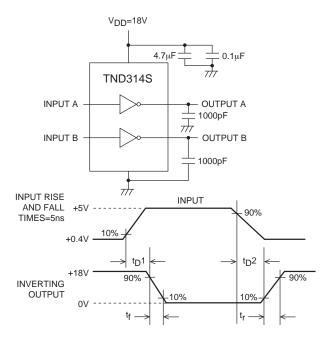
unit : mm (typ) 7005-007

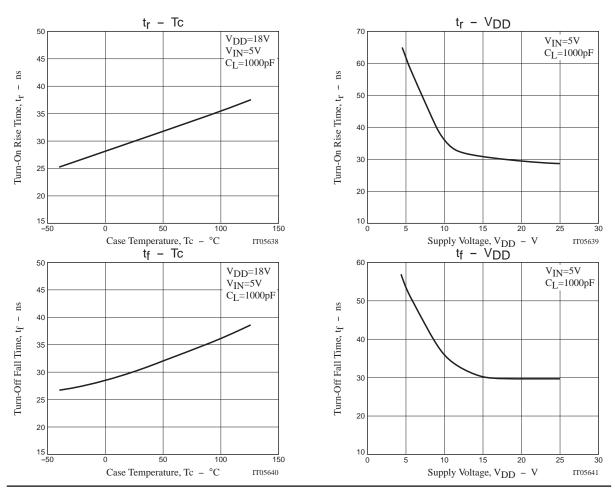


Block Diagram

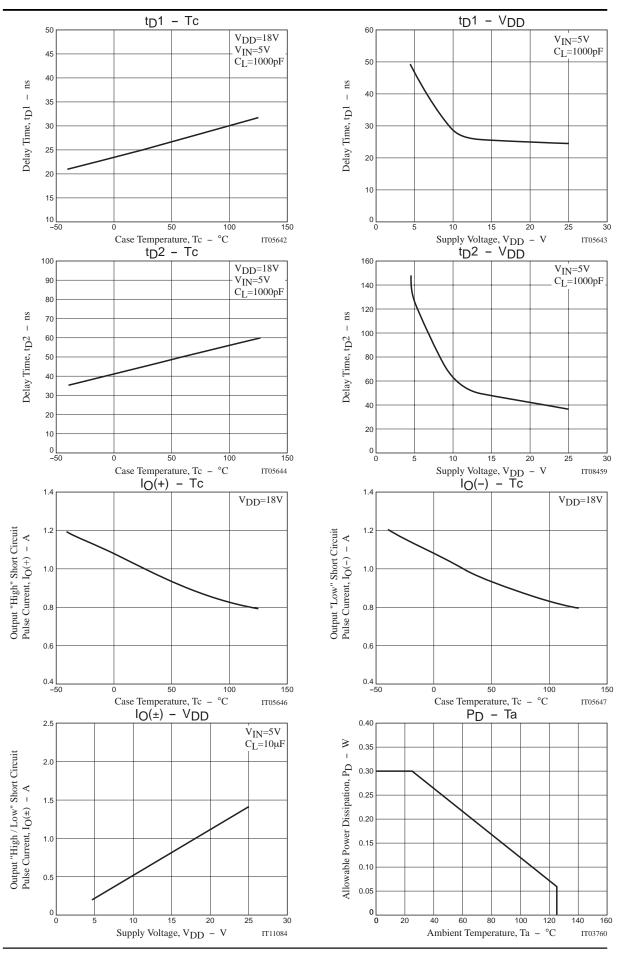


Switching Time Test Circuit





No. A0420-3/5



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